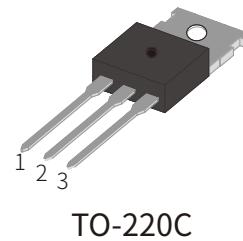


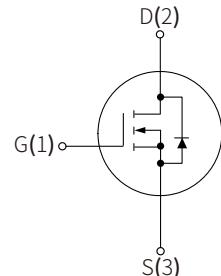
FEATURES

- | Advanced trench cell design
- | Low Thermal Resistance
- | Super Trench



APPLICATIONS

- | Motor drivers
- | DC - DC Converters



APPROVALS

| | |
|-------------|------------------------------------|
| RoHS | Compliance with 2011/65/EU |
| HF | Compliance with IEC61249-2-21:2003 |

ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
|--|------------------|--|------|------|----------|------------------|
| Drain-source voltage | V_{DSS} | $T_j = 25^\circ\text{C}$ to 150°C | | | 500 | V |
| Drain-gate voltage | V_{DGR} | $T_j = 25^\circ\text{C}$ to 150°C ; $R_{GS} = 20\text{ k}\Omega$ | | | 500 | V |
| Gate-source voltage | V_{GS} | | | | ± 30 | V |
| Continuous drain current | I_D | $T_{mb} = 25^\circ\text{C}$; $V_{GS} = 10\text{ V}$ | | | 8.5 | A |
| | | $T_{mb} = 100^\circ\text{C}$; $V_{GS} = 10\text{ V}$ | | | 5.4 | |
| Pulsed drain current | I_{DM} | $T_{mb} = 25^\circ\text{C}$ | | | 34 | A |
| Total dissipation | P_D | $T_{mb} = 25^\circ\text{C}$ | | | 147 | W |
| Operating junction and storage temperature range | T_j, T_{stg} | | -55 | | 150 | $^\circ\text{C}$ |
| Non-repetitive avalanche energy | E_{AS} | Unclamped inductive load, $I_{AS} = 7.4\text{ A}$; $t_p = 0.22\text{ ms}$; T_j prior to avalanche = 25°C ; $V_{DD} \leqslant 50\text{ V}$; $R_{GS} = 50\text{ }\Omega$; $V_{GS} = 10\text{ V}$; refer to fig:17 | | | 531 | mJ |
| Repetitive avalanche energy ^(Notes1) | E_{AR} | $I_{AR} = 8.5\text{ A}$; $t_p = 2.5\text{ }\mu\text{s}$; T_j prior to avalanche = 25°C ; $R_{GS} = 50\text{ }\Omega$; $V_{GS} = 10\text{ V}$; refer to fig:18 | | | 13 | mJ |
| Repetitive and non-repetitive avalanche current | I_{AS}, I_{AR} | | | | 8.5 | A |
| Thermal resistance junction | $R_{th,j-mb}$ | in free air | | | 0.85 | K/W |
| Thermal resistance junction | $R_{th,j-a}$ | in free air | | | 60 | K/W |

Notes: (1) pulse width and repetition rate limited by T_j max.

ELECTRICAL CHARACTERISTICS($T_A=25^\circ\text{C}$)

| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
|--|-----------------------------|--|------|------|------|---------------|
| Drain-source Breakdown Voltage | $V_{(\text{BR})\text{DSS}}$ | $V_{GS}=0\text{V}, I_D=0.25\text{mA}$ | 500 | | | V |
| Drain-source Breakdown Voltage Temperature Coefficient | $V_{(\text{BR})\text{DSS}}$ | $V_{DS}=V_{GS}, I_D=0.25\text{mA}$ | | 0.1 | | %/K |
| Drain-source On Resistance | $R_{DS(\text{on})}$ | $V_{GS}=10\text{V}, I_D=4.8\text{A}$ | | 0.6 | 0.85 | Ω |
| Gate Threshold Voltage | $V_{GS(\text{TO})}$ | $V_{DS}=V_{GS}, I_D=0.25\text{mA}$ | 2 | 3 | 4 | V |
| Forward Transconductance | g_{fs} | $V_{DS}=30\text{V}, I_D=4.8\text{A}$ | 3.5 | 6 | | S |
| Drain-source Leakage Current | I_{DSS} | $V_{DS}=500\text{V}, V_{GS}=0\text{V}$ | | 1 | 25 | μA |
| | | $V_{DS}=400\text{V}, V_{GS}=0\text{V}, T_j=125^\circ\text{C}$ | | 40 | 250 | |
| Gate-source Leakage Current | I_{GSS} | $V_{GS}=\pm 30\text{V}, V_{DS}=0\text{V}$ | 10 | 200 | | nA |
| Total Gate Charge | $Q_{Qg(\text{tot})}$ | $I_D = 8.5 \text{ A}; V_{DD} = 400 \text{ V}; V_{GS} = 10 \text{ V}$ | | 55 | 80 | nC |
| Gate Source Charge | Q_{gs} | | | 5.5 | 7 | |
| Gate-drain (Miller) Charge | Q_{gd} | | | 30 | 45 | |
| Turn-on Delay Time | $t_{d(\text{on})}$ | | | 18 | | ns |
| Turn-on Rise Time | t_r | $V_{DD} = 250 \text{ V}; R_D = 30 \Omega; R_G = 9.1 \Omega$ | | 37 | | |
| Turn-off Delay Time | $t_{d(\text{off})}$ | | | 80 | | |
| Turn-off Fall Time | t_f | | | 36 | | |
| Internal Drain Inductance | L_d | Measured from tab to centre of die | | 3.5 | | nH |
| Internal Drain Inductance | L_d | Measured from drain lead to centre of die | | 4.5 | | |
| Internal Source Inductance | L_s | Measured from source lead to source bond pad | | 7.5 | | |
| Input Capacitance | C_{iss} | | | 960 | | |
| Output Capacitance | C_{oss} | $V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$ | | 140 | | pF |
| Feedback Capacitance | C_{rss} | | | 80 | | |

Source-drain Diode Ratings And Characteristics

| | | | | | |
|--|----------|--|-----|-----|---------------|
| Continuous Source Current (Body Diode) | I_s | $T_{mb} = 25^\circ\text{C}$ | | 8.5 | A |
| Pulsed Source Current (Body Diode) | I_{SM} | $T_{mb} = 25^\circ\text{C}$ | | 34 | A |
| Diode Forward Voltage | V_{SD} | $I_s = 8.5 \text{ A}; V_{GS} = 0 \text{ V}$ | | 1.2 | V |
| Reverse Recovery Time | t_{rr} | $I_s = 8.5 \text{ A}; V_{GS} = 0 \text{ V}; dI/dt = 100 \text{ A}/\mu\text{s}$ | 440 | | ns |
| Reverse Recovery Charge | Q_{rr} | | 6.4 | | μC |

PARAMETER CHARACTERISTIC CURVE

Figure 1: Normalised power dissipation.
 $P_D\% = 100 \cdot P_D / P_{D25^\circ C} = f(T_{mb})$

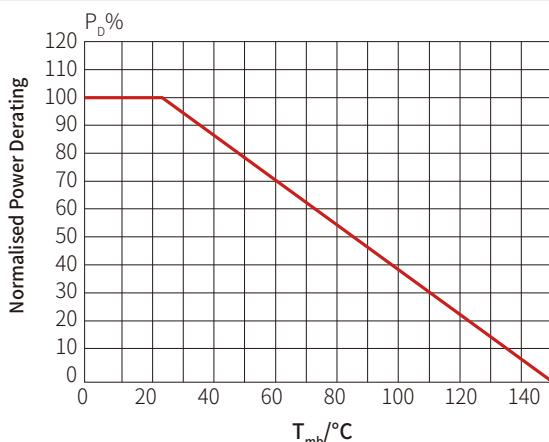


Figure 2: Normalised continuous drain current.
 $ID\% = 100 \cdot ID / I_{D25^\circ C} = f(T_{mb})$; conditions: $V_{GS} \geq 10 V$

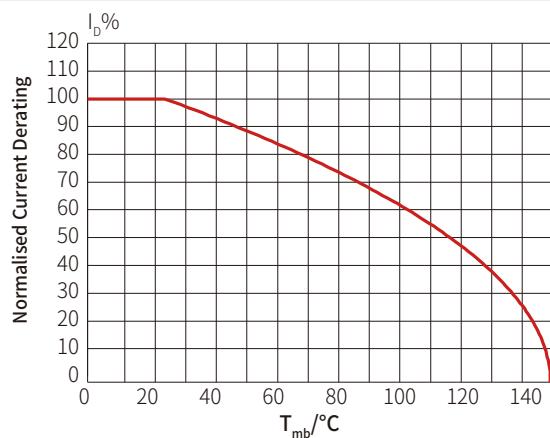


Figure 3: Safe operating area. $T_{mb} = 25^\circ C$
 I_D & I_{DM} = $f(V_{DS})$; I_{DM} single pulse; parameter t_p

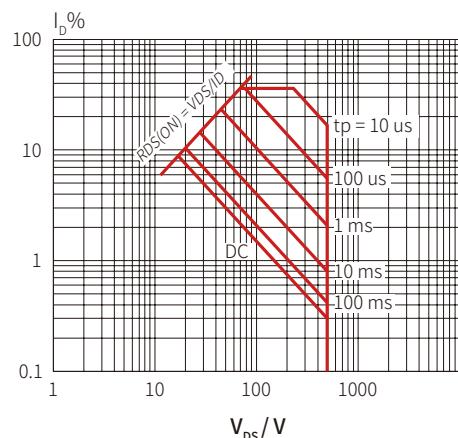


Figure 4: Transient thermal impedance.
 $Z_{thj-mb} = f(t)$; parameter $D = t_p/T$

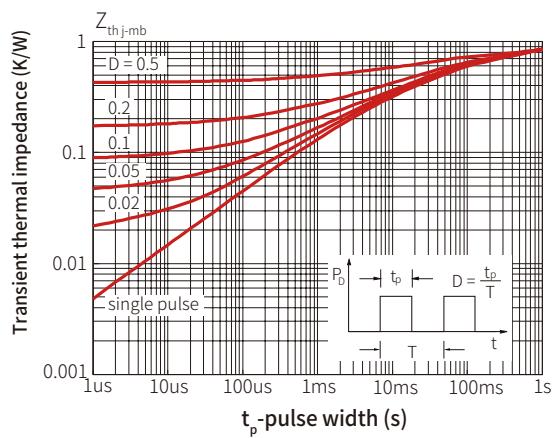


Figure 5: Typical output characteristics.
 $I_D = f(V_{DS})$; parameter V_{GS}

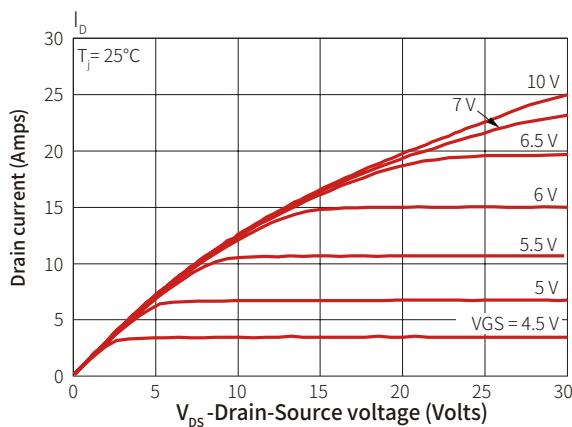


Figure 6: Typical on-state resistance.
 $R_{DS(on)} = f(I_D)$; parameter V_{GS}

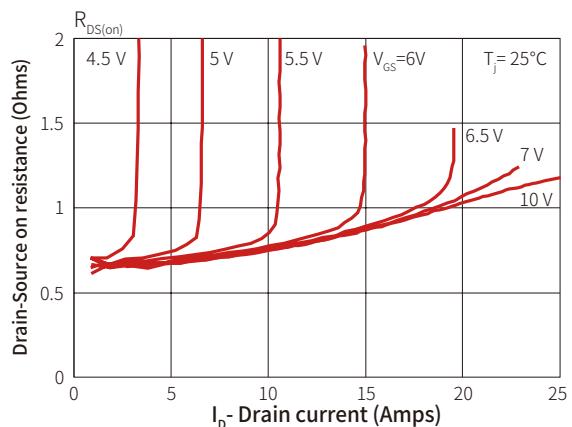


Figure 7: Typical transfer characteristics.
 $I_D = f(V_{GS})$; parameter T_j

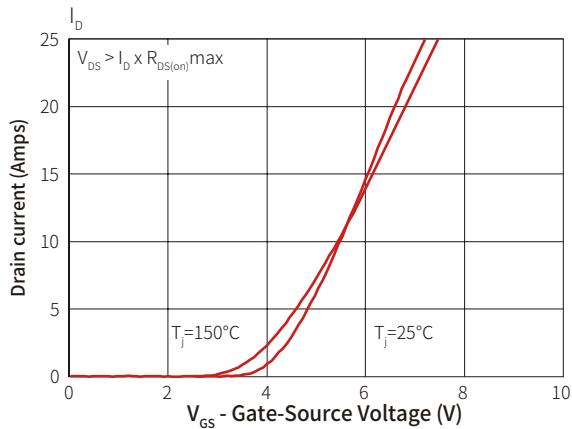


Figure 8: Typical transconductance.
 $g_{fs} = f(I_D)$; parameter T_j

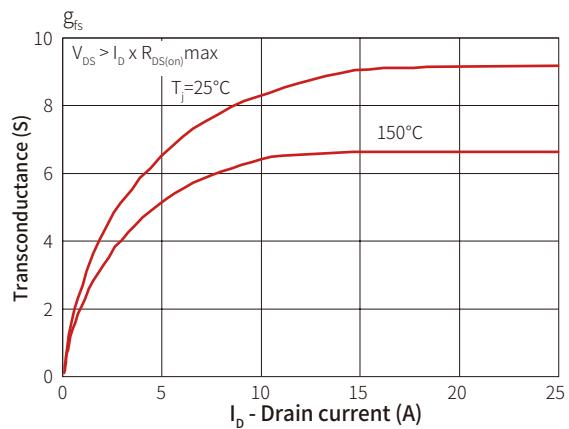


Figure 9: Normalised drain-source on-state resistance.
 $a = R_{DS(ON)}/R_{DS(ON)} 25^\circ\text{C} = f(T_j)$; $I_D = 4.25\text{ A}$; $V_{GS} = 10\text{ V}$

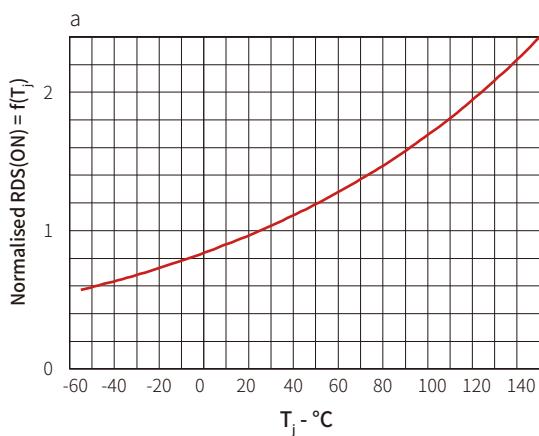


Figure 10: Gate threshold voltage.
 $V_{GS(TO)} = f(T_j)$; conditions: $I_D = 0.25\text{ mA}$; $V_{DS} = V_{GS}$

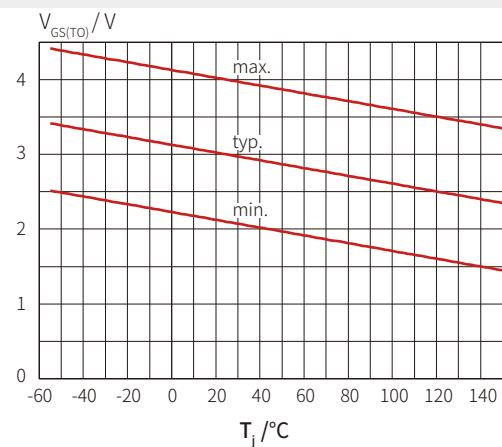


Figure 11: Sub-threshold drain current.
 $I_D = f(V_{GS})$; conditions: $T_j = 25^\circ\text{C}$; $V_{DS} = V_{GS}$

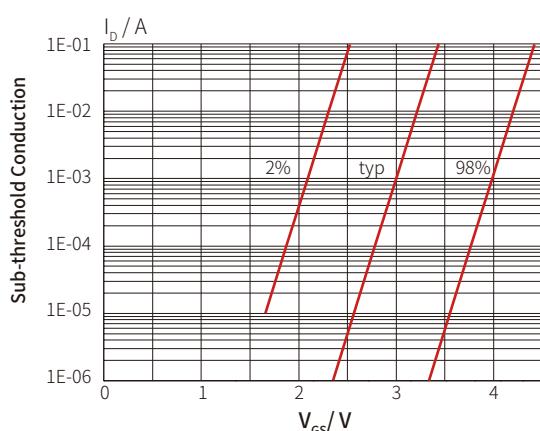


Figure 12: Typical capacitances, C_{iss} , C_{oss} , C_{rss} .
 $C = f(V_{DS})$; conditions: $V_{GS} = 0\text{ V}$; $f = 1\text{ MHz}$

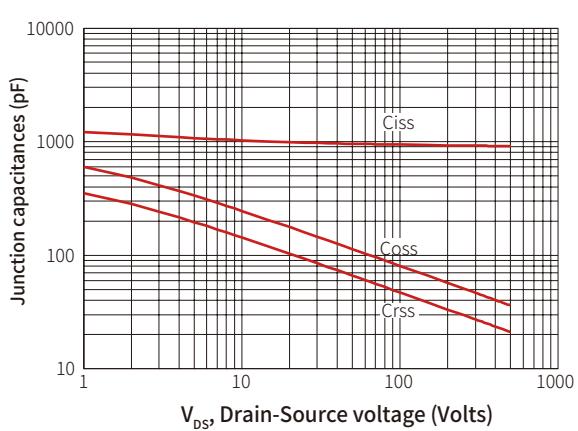


Figure 13: Typical turn-on gate-charge characteristics. $V_{GS} = f(Q_G)$; parameter V_{DS}

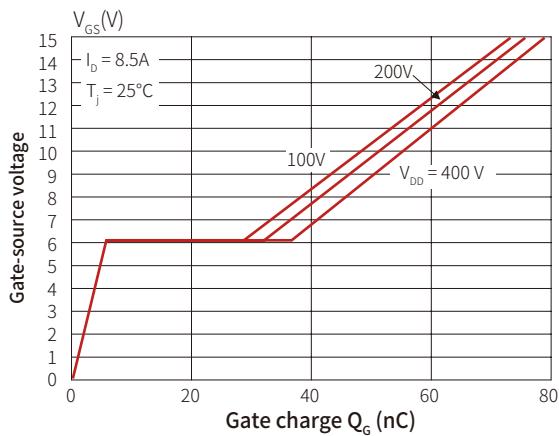


Figure 14: Typical switching times; $t_{d(on)}, t_r, t_{d(off)}, t_f = f(R_G)$

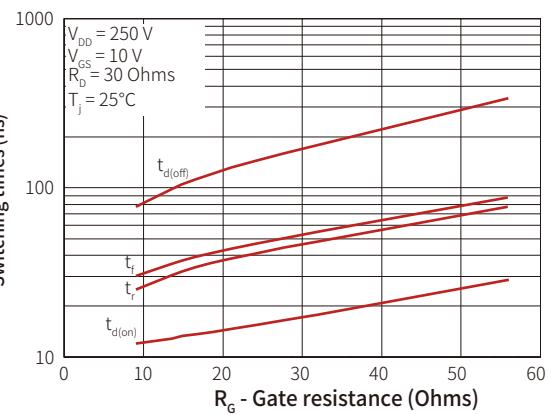


Figure 15: Normalised drain-source breakdown voltage; $V_{(BR)DSS}/V_{(BR)DSS \text{ at } 25^\circ\text{C}} = f(T_j)$

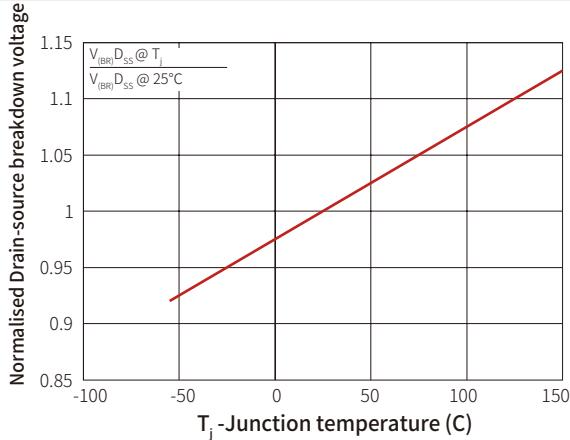


Figure 16: Source-Drain diode characteristic. $I_F = f(V_{SDS})$; parameter T_j

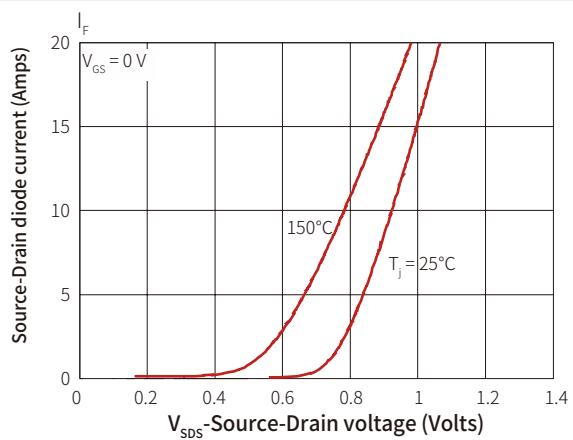


Figure 17: Maximum permissible non-repetitive avalanche current (I_{AS}) versus avalanche time (t_p); unclamped inductive load

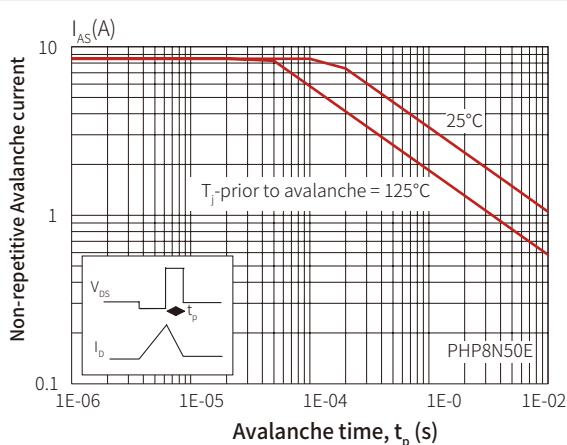
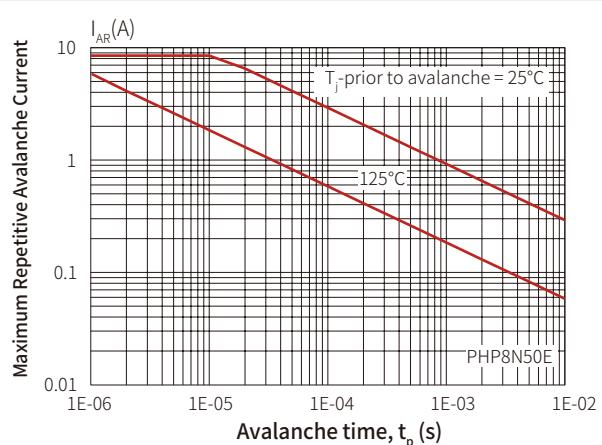
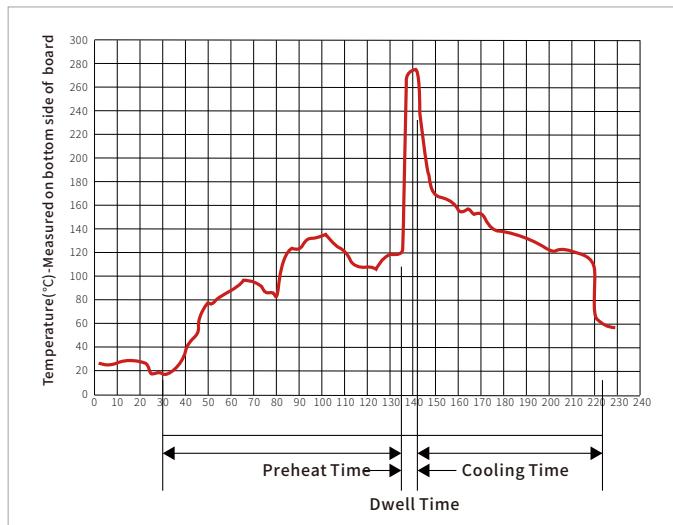


Figure 18: Maximum permissible repetitive avalanche current (I_{AR}) versus avalanche time (t_p)

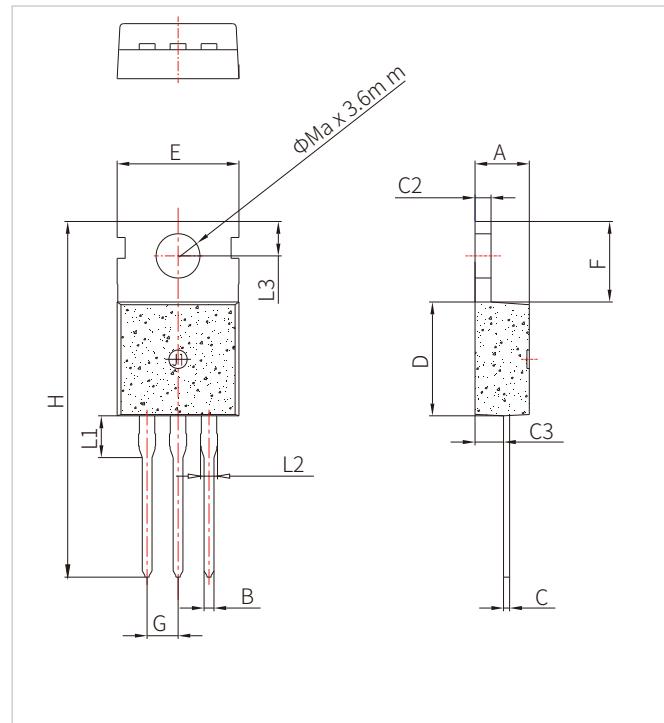


WAVE SOLDERING



| | Wave Parameter | Lead-free assembly |
|----------|------------------------|--------------------|
| Pre Heat | Temperature Min | 100°C |
| | Temperature Max | 150°C |
| | Time(min to max) | 60 – 180 secs |
| | Solder pot Temperature | 280°C Max |
| | Solder Dwell Time | 2-5 seconds |

TO-220C PACKAGE MECHANICAL DATA



| Ref. | Dimensions | | | | | |
|------|-------------|------|------|--------|-------|-------|
| | Millimeters | | | Inches | | |
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 4.30 | | 4.70 | 0.169 | | 0.185 |
| B | 0.70 | | 0.90 | 0.028 | | 0.035 |
| C | 0.45 | | 0.60 | 0.018 | | 0.024 |
| C2 | 1.23 | | 1.32 | 0.048 | | 0.052 |
| C3 | 2.20 | | 2.60 | 0.087 | | 0.102 |
| D | 8.80 | | 10.0 | 0.346 | | 0.394 |
| E | 9.90 | | 10.3 | 0.390 | | 0.406 |
| F | 6.30 | | 6.90 | 0.248 | | 0.272 |
| G | | 2.54 | | | 0.1 | |
| H | 28.0 | | 30.0 | 1.102 | | 1.181 |
| L1 | | 3.65 | | | 0.144 | |
| L2 | 1.14 | | 1.70 | 0.045 | | 0.067 |
| L3 | 2.65 | | 2.95 | 0.104 | | 0.116 |
| Ø | | 3.6 | | | 0.142 | |

ORDERING INFORMATION

| Part Number | Package | Qty/pcs | | |
|-------------|---------|---------|-----------|--------|
| | | Tube | Inner Box | Carton |
| IRF840 | TO-220C | 50 | 1000 | 5000 |

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